

Precision $\pm 1.7 g$, $\pm 5 g$, $\pm 18 g$ Single-/ Dual-Axis *i*MEMS[®] Accelerometer

Data Sheet

ADXL103/ADXL203

FEATURES

High performance, single-/dual-axis accelerometer on a single IC chip 5 mm × 5 mm × 2 mm LCC package 1 mg resolution at 60 Hz Low power: 700 μ A at V_s = 5 V (typical) High zero *q* bias stability High sensitivity accuracy -40°C to +125°C temperature range X and Y axes aligned to within 0.1° (typical) Bandwidth adjustment with a single capacitor Single-supply operation 3500 g shock survival **RoHS compliant** Compatible with Sn/Pb- and Pb-free solder processes

APPLICATIONS

Platform stabilization/leveling Navigation **Alarms and motion detectors** High accuracy, 2-axis tilt sensing Vibration monitoring and compensation Abuse event detection

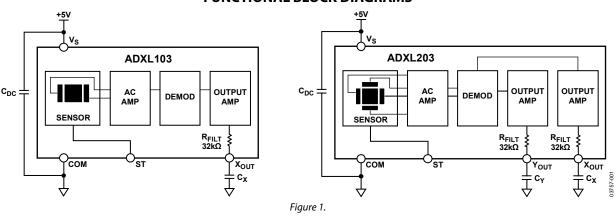
GENERAL DESCRIPTION

The ADXL103/ADXL203 are high precision, low power, complete single- and dual-axis accelerometers with signal conditioned voltage outputs, all on a single, monolithic IC. The ADXL103/ ADXL203 measure acceleration with a full-scale range of ± 1.7 g, ±5 g, or ±18 g. The ADXL103/ADXL203 can measure both dynamic acceleration (for example, vibration) and static acceleration (for example, gravity).

The typical noise floor is 110 $\mu g/\sqrt{Hz}$, allowing signals below 1 mg (0.06° of inclination) to be resolved in tilt sensing applications using narrow bandwidths (<60 Hz).

The user selects the bandwidth of the accelerometer using Capacitor C_x and Capacitor C_y at the X_{OUT} and Y_{OUT} pins. Bandwidths of 0.5 Hz to 2.5 kHz can be selected to suit the application.

The ADXL103 and ADXL203 are available in a 5 mm \times 5 mm \times 2 mm, 8-terminal ceramic LCC package.



FUNCTIONAL BLOCK DIAGRAMS

Document Feedback

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TABLE OF CONTENTS

| Features | 1 |
|--|---|
| Applications | 1 |
| General Description | 1 |
| Functional Block Diagrams | 1 |
| Revision History | 2 |
| Specifications | 3 |
| Absolute Maximum Ratings | 4 |
| ESD Caution | 4 |
| Pin Configurations and Function Descriptions | 5 |
| Typical Performance Characteristics | 6 |
| ADXL103 and ADXL203 | 6 |
| AD22293 | 9 |
| AD22035 and AD220371 | 0 |
| All Models | 2 |

REVISION HISTORY

5/2018—Rev. E to Rev. F

| Changes to Features Section and Applications Section | 1 |
|--|----|
| Changes to Noise Parameter, Table 1 | |
| Changes to Ordering Guide | 16 |
| Deleted Automotive Products Section | |

1/2014—Rev. D to Rev. E

| Changes to Ordering | Guide 1 | 6 |
|---------------------|---------|---|
|---------------------|---------|---|

9/2011-Rev. C to Rev. D

| Added AD22293, AD22035, and AD22037 Throughout |
|--|
| Changes to Application Section and General Description |
| Section |
| Changes to Table 1 |
| Deleted Figure 13 and Figure 14: Renumbered Sequentially 7 |
| Deleted Figure 17 and Figure 22 |
| Added Figure 19 to Figure 24; Renumbered Sequentially9 |
| Added Figure 25 to Figure 3410 |
| Added All Models Section, Figure 35 to Figure 38 12 |
| Changes to Figure 39 13 |
| Changes to Ordering Guide16 |
| Changes to Automotive Products Section16 |
| |
| 5/2010—Rev. B to Rev. C |
| Changes to Figure 24 Caption |

| Changes to Figure 24 Caption12 | |
|-------------------------------------|--|
| Added Automotive Products Section12 | |

| Theory of Operation |
|--|
| Performance13 |
| Applications Information14 |
| Power Supply Decoupling14 |
| Setting the Bandwidth Using $C_{\rm X}$ and $C_{\rm Y}$ 14 |
| Self Test 14 |
| Design Trade-Offs for Selecting Filter Characteristics: The Noise/Bandwidth Trade-Off14 |
| Using the ADXL103/ADXL203 with Operating Voltages Other than 5 V |
| Using the ADXL203 as a Dual-Axis Tilt Sensor |
| Outline Dimensions |
| Ordering Guide16 |

4/2010-Rev. A to Rev. B

| Changes to Features Section | 1 |
|-----------------------------|----|
| Updated Outline Dimensions | 12 |
| Changes to Ordering Guide | 12 |
| 6 6 | |

2/2006—Rev. 0 to Rev. A

| Changes to Features | 1 |
|------------------------------------|---|
| Changes to Table 1 | |
| Changes to Figure 2 | |
| Changes to Figure 3 and Figure 4 | |
| Changes to the Performance Section | |

4/2004—Revision 0: Initial Version

SPECIFICATIONS

 $T_A = -40^{\circ}$ C to $+125^{\circ}$ C, $V_S = 5$ V, $C_X = C_Y = 0.1 \mu$ F, acceleration = 0 g, unless otherwise noted. All minimum and maximum specifications are guaranteed. All typical specifications are not guaranteed.

| | | ADXL103/ADXL203 | | | AD22293 | | | AD22035/AD22037 | | | |
|---|----------------------------|-----------------|------|-------|---------|------|-------|-----------------|------|-------|--------------|
| Parameter | Test Conditions | Min | Тур | Max | Min | Тур | Max | Min | Тур | Max | Unit |
| SENSOR | Each axis | | | | | | | | | | |
| Measurement Range ¹ | | ±1.7 | | | ±5 | ±6 | | ±18 | | | g |
| Nonlinearity | % of full scale | | ±0.2 | ±1.25 | | ±0.2 | ±1.25 | | ±0.2 | ±1.25 | % |
| Package Alignment Error | | | ±1 | | | ±1 | | | ±1 | | Degrees |
| Alignment Error (ADXL203) | X to Y sensor | | ±0.1 | | | ±0.1 | | | ±0.1 | | Degrees |
| Cross-Axis Sensitivity | | | ±1.5 | ±3 | | ±1.5 | ±3 | | ±1.5 | ±3 | % |
| SENSITIVITY (RATIOMETRIC) ² | Each axis | | | | | | | | | | |
| Sensitivity at XOUT, YOUT | $V_s = 5 V$ | 960 | 1000 | 1040 | 293 | 312 | 331 | 94 | 100 | 106 | mV/ <i>g</i> |
| Sensitivity Change Due to Temperature ³ | $V_S = 5 V$ | | ±0.3 | | | ±0.3 | | | ±0.3 | | % |
| ZERO g BIAS LEVEL (RATIOMETRIC) | Each axis | | | | | | | | | | |
| 0 g Voltage at Хоит, Youт | $V_s = 5 V$ | 2.4 | 2.5 | 2.6 | 2.4 | 2.5 | 2.6 | 2.4 | 2.5 | 2.6 | V |
| Initial 0 g Output Deviation from Ideal | V _s = 5 V, 25°C | | ±25 | | | ±50 | | | ±125 | | m <i>g</i> |
| 0 g Offset vs. Temperature | | | ±0.1 | ±0.8 | | ±0.3 | ±1.8 | | ±1 | | mg∕°C |
| NOISE | | | | | | | | | | | |
| Output Noise | | | 1 | 3 | | 0.4 | | | 0.2 | | mV rms |
| Noise Density | | | 110 | | | 130 | | | 230 | | µg/√Hz rms |
| FREQUENCY RESPONSE ⁴ | | | | | | | | | | | |
| C _x , C _Y Range⁵ | | 0.002 | | 10 | 0.002 | | 10 | 0.002 | | 10 | μF |
| R _{FILT} Tolerance | | 24 | 32 | 40 | 24 | 32 | 40 | 24 | 32 | 40 | kΩ |
| Sensor Resonant Frequency | | | 5.5 | | | 5.5 | | | 5.5 | | kHz |
| SELF TEST ⁶ | | | | | | | | | | | |
| Logic Input Low | | | | 1 | | | 1 | | | 1 | V |
| Logic Input High | | 4 | | | 4 | | | 4 | | | V |
| ST Input Resistance to GND | | 30 | 50 | | 30 | 50 | | 30 | 50 | | kΩ |
| Output Change at Xout, Yout | ST 0 to ST 1 | 450 | 750 | 1100 | 125 | 250 | 375 | 60 | 80 | 100 | mV |
| OUTPUT AMPLIFIER | | | | | | | | | | | |
| Output Swing Low | No load | 0.05 | 0.2 | | 0.05 | 0.2 | | 0.05 | 0.2 | | V |
| Output Swing High | No load | | 4.5 | 4.8 | | 4.5 | 4.8 | | 4.5 | 4.8 | V |
| POWER SUPPLY (VDD) | | | | | | | | | | | |
| Operating Voltage Range | | 3 | | 6 | 3 | | 6 | 3 | | 6 | V |
| Quiescent Supply Current | | | 0.7 | 1.1 | | 0.7 | 1.1 | | 0.7 | 1.1 | mA |
| Turn-On Time ⁷ | | | 20 | | | 20 | | | 20 | | ms |

 1 Guaranteed by measurement of initial offset and sensitivity. 2 Sensitivity is essentially ratiometric to Vs. For Vs = 4.75 V to 5.25 V, sensitivity is 186 mV/V/g to 215 mV/V/g.

³ Defined as the output change from ambient-to-maximum temperature or ambient-to-minimum temperature.

⁴ Actual frequency response controlled by user-supplied external capacitor (C_x, C_Y).

⁵ Bandwidth = $1/(2 \times \pi \times 32 \text{ k}\Omega \times \text{C})$. For C_x, C_Y = 0.002 μ F, bandwidth = 2500 Hz. For C_x, C_Y = 10 μ F, bandwidth = 0.5 Hz. Minimum/maximum values are not tested. ⁶ Self-test response changes cubically with Vs.

 7 Larger values of C_x, C_Y increase turn-on time. Turn-on time is approximately 160 × C_x or C_Y + 4 ms, where C_x, C_Y are in µF.

ABSOLUTE MAXIMUM RATINGS

Table 2.

| Table 2. | | | | | |
|--|--|--|--|--|--|
| Parameter | Rating | | | | |
| Acceleration (Any Axis, Unpowered) | 3500 g | | | | |
| Acceleration (Any Axis, Powered) | 3500 g | | | | |
| Drop Test (Concrete Surface) | 1.2 m | | | | |
| Vs | –0.3 V to +7.0 V | | | | |
| All Other Pins | (COM – 0.3 V) to (V _s + 0.3 V) | | | | |
| Output Short-Circuit Duration (Any Pin to Common) | Indefinite | | | | |
| Temperature Range (Powered) | –55°C to +125°C | | | | |
| Temperature Range (Storage) | –65°C to +150°C | | | | |

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

Table 3. Package Characteristics

| Package Type | θ _{JA} | θ _{JC} | Device Weight | | |
|------------------------|-----------------|-----------------|---------------|--|--|
| 8-Terminal Ceramic LCC | 120°C/W | 20°C/W | <1.0 gram | | |

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

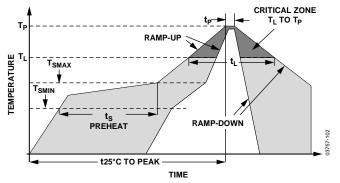


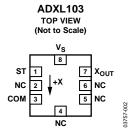
Figure 2. Recommended Soldering Profile

Table 4. Solder Profile Parameters

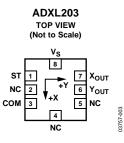
| | Test Condition | | | |
|--|---------------------------|---------------------------|--|--|
| Profile Feature | Sn63/Pb37 | Pb-Free | | |
| Average Ramp Rate (T_L to T_P) | 3°C/second maximum | 3°C/second maximum | | |
| Preheat | | | | |
| Minimum Temperature (T _{SMIN}) | 100°C | 150°C | | |
| Maximum Temperature (T _{SMAX}) | 150°C | 200°C | | |
| Time (T _{SMIN} to T _{SMAX}) (t _s) | 60 seconds to 120 seconds | 60 seconds to 150 seconds | | |
| T _{SMAX} to T _L | | | | |
| Ramp-Up Rate | 3°C/second | 3°C/second | | |
| Time Maintained Above Liquidous (TL) | | | | |
| Liquidous Temperature (T∟) | 183°C | 217°C | | |
| Time (t _L) | 60 seconds to 150 seconds | 60 seconds to 150 seconds | | |
| Peak Temperature (T _P) | 240°C + 0°C/–5°C | 260°C + 0°C/-5°C | | |
| Time Within 5°C of Actual Peak Temperature (t _P) | 10 seconds to 30 seconds | 20 seconds to 40 seconds | | |
| Ramp-Down Rate | 6°C/second maximum | 6°C/second maximum | | |
| Time 25°C to Peak Temperature | 6 minutes maximum | 8 minutes maximum | | |

ADXL103/ADXL203

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS



NOTES 1. NC = NO CONNECT. DO NOT CONNECT TO THIS PIN. Figure 3. ADXL103 Pin Configuration



NOTES 1. NC = NO CONNECT. DO NOT CONNECT TO THIS PIN. Figure 4. ADXL203 Pin Configuration

Table 5. ADXL103 Pin Function Descriptions

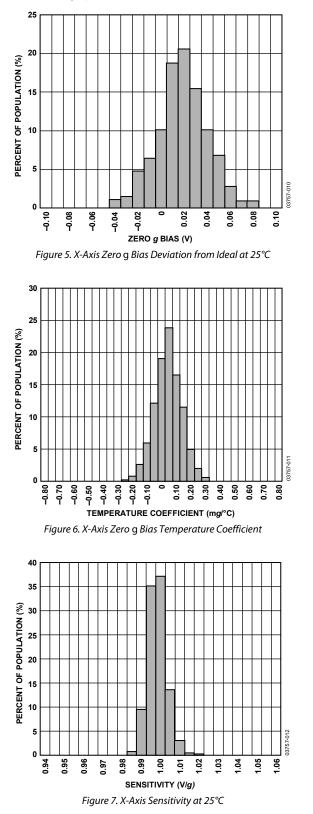
Table 6. ADXL203 Pin Function Descriptions

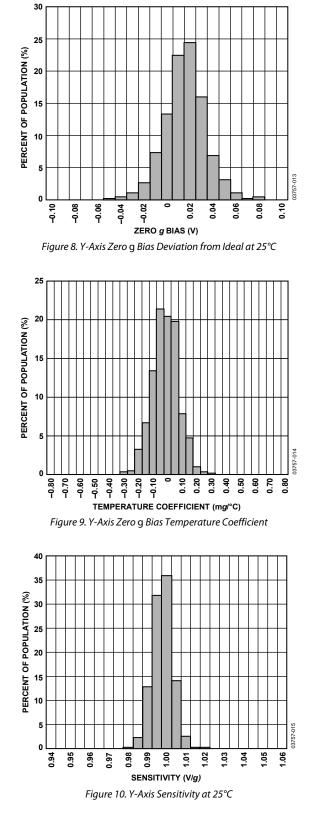
| Pin No. | Mnemonic | Description | Pin No. | Mnemonic | Description |
|---------|----------|------------------|---------|------------------|------------------|
| 1 | ST | Self Test | 1 | ST | Self Test |
| 2 | NC | Do Not Connect | 2 | NC | Do Not Connect |
| 3 | СОМ | Common | 3 | СОМ | Common |
| 4 | NC | Do Not Connect | 4 | NC | Do Not Connect |
| 5 | NC | Do Not Connect | 5 | NC | Do Not Connect |
| 6 | NC | Do Not Connect | 6 | Y _{OUT} | Y Channel Output |
| 7 | Xout | X Channel Output | 7 | Xout | X Channel Output |
| 8 | Vs | 3 V to 6 V | 8 | Vs | 3 V to 6 V |

TYPICAL PERFORMANCE CHARACTERISTICS

ADXL103 AND ADXL203

 $V_s = 5 V$ for all graphs, unless otherwise noted.

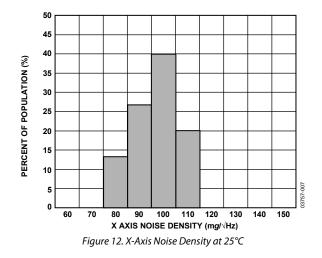




Data Sheet

2.60 2.58 2.56 2.54 VOLTAGE (1V/g) 2.52 2.50 2.48 2.46 2.44 2.42 03757-004 2.40 7 6 7 7 7 0 3 9 TEMPERATURE (°C)

Figure 11. Zero g Bias vs. Temperature; Devices Soldered to PCB



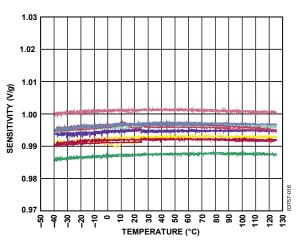
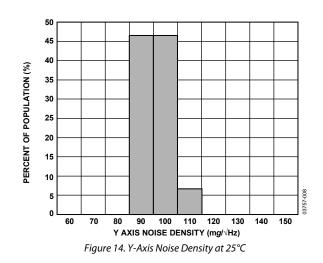


Figure 13. Sensitivity vs. Temperature; Devices Soldered to PCB



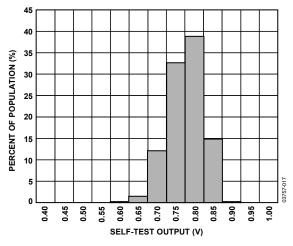


Figure 15. X-Axis Self-Test Response at 25°C

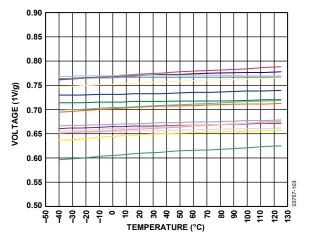


Figure 16. Self-Test Response vs. Temperature

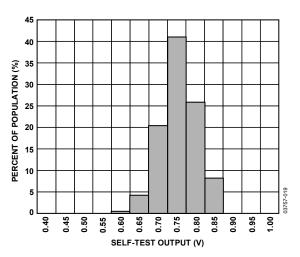
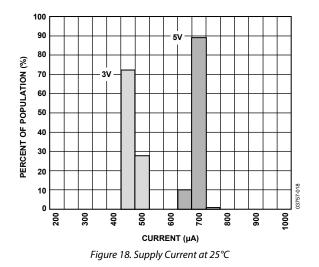
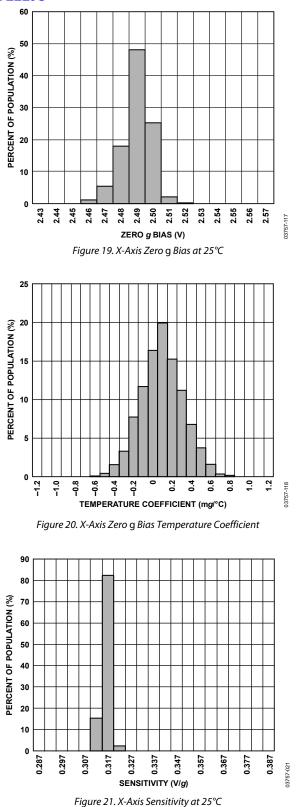


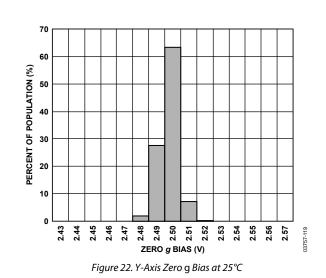
Figure 17. Y-Axis Self-Test Response at 25°C



Data Sheet







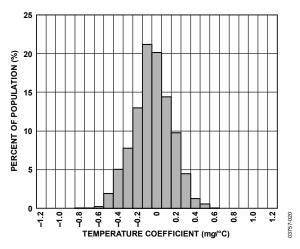
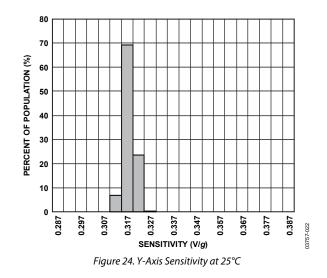


Figure 23. Y-Axis Zero g Bias Temperature Coefficient



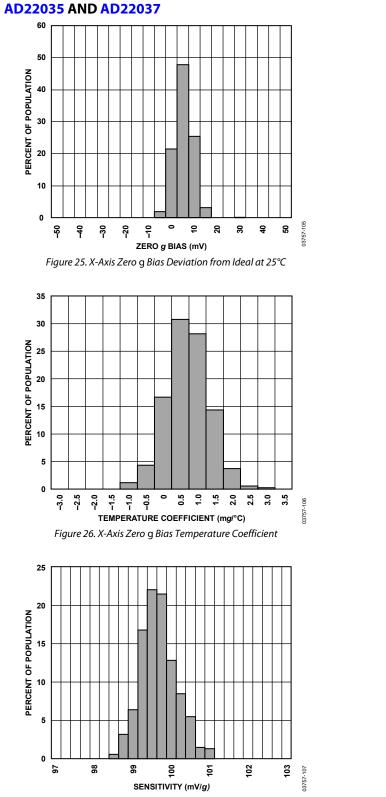


Figure 27. X-Axis Sensitivity at 25°C

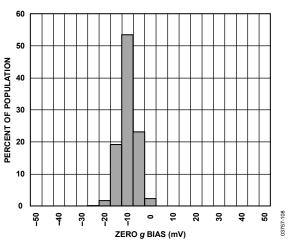
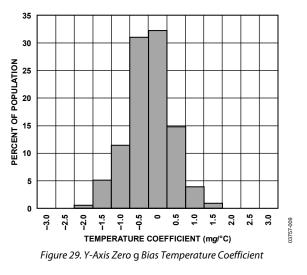
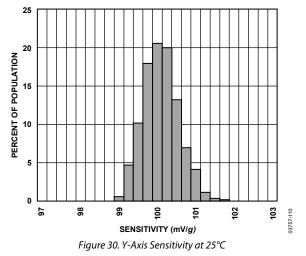
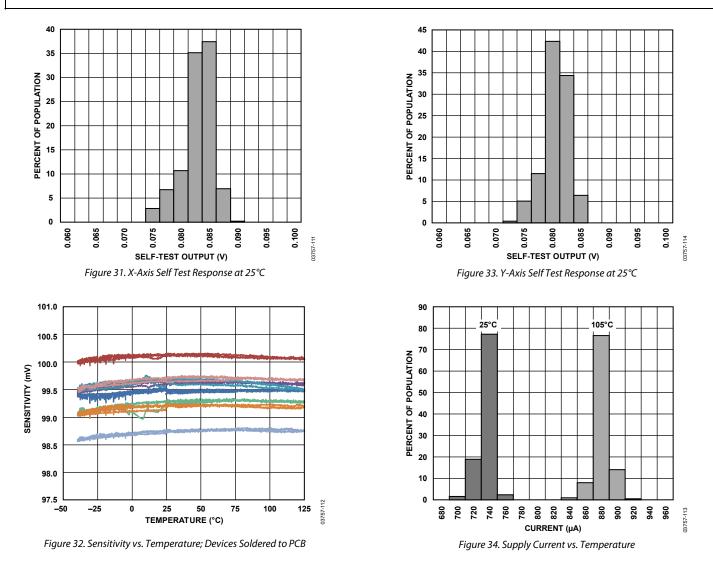


Figure 28. Y-Axis Zero g Bias Deviation from Ideal at 25°C

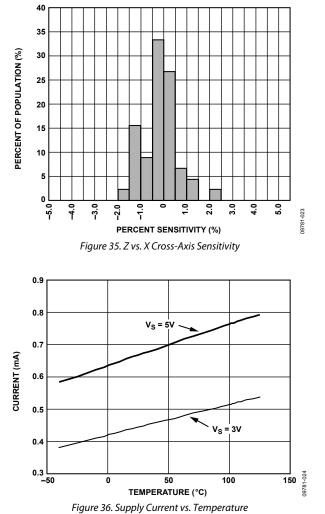




Data Sheet



ALL MODELS



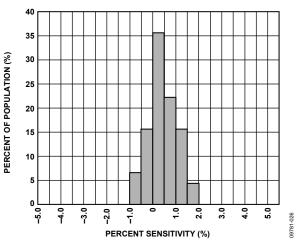


Figure 37. Z vs. Y Cross-Axis Sensitivity

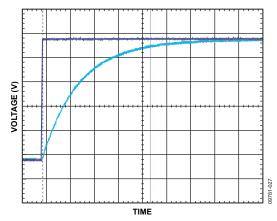


Figure 38. Turn-On Time; C_{X} , $C_{Y} = 0.1 \mu$ F, Time Scale = 2 ms/DIV

THEORY OF OPERATION

The ADXL103/ADXL203 are complete acceleration measurement systems on a single, monolithic IC. The ADXL103 is a singleaxis accelerometer, and the ADXL203 is a dual-axis accelerometer. Both devices contain a polysilicon surface micromachined sensor and signal conditioning circuitry to implement an open-loop acceleration measurement architecture. The output signals are analog voltages that are proportional to acceleration. The ADXL103/ADXL203 are capable of measuring both positive and negative accelerations from ± 1.7 g to at least ± 18 g. The accelerometer can measure static acceleration forces, such as gravity, allowing it to be used as a tilt sensor.

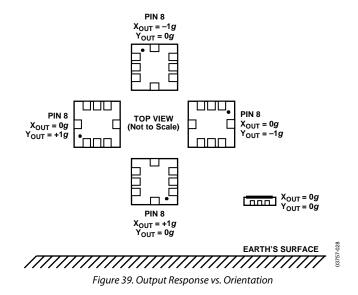
The sensor is a surface micromachined polysilicon structure built on top of the silicon wafer. Polysilicon springs suspend the structure over the surface of the wafer and provide a resistance against acceleration forces. Deflection of the structure is measured using a differential capacitor that consists of independent fixed plates and plates attached to the moving mass. The fixed plates are driven by 180° out-of-phase square waves. Acceleration deflects the beam and unbalances the differential capacitor, resulting in an output square wave whose amplitude is proportional to acceleration. Phase-sensitive demodulation techniques then rectify the signal and determine the direction of the acceleration. The output of the demodulator is amplified and brought off-chip through a 32 k Ω resistor. At this point, the user can set the signal bandwidth of the device by adding a capacitor. This filtering improves measurement resolution and helps prevent aliasing.

PERFORMANCE

Rather than using additional temperature compensation circuitry, innovative design techniques ensure high performance is built in. As a result, there is essentially no quantization error or nonmonotonic behavior, and temperature hysteresis is very low (typically less than 10 mg over the -40° C to $+125^{\circ}$ C temperature range).

Figure 11 shows the 0 *g* output performance of eight devices (x and y axes) over a -40° C to $+125^{\circ}$ C temperature range.

Figure 13 demonstrates the typical sensitivity shift over temperature for $V_s = 5$ V. Sensitivity stability is optimized for $V_s = 5$ V but is still very good over the specified range; it is typically better than ±1% over temperature at $V_s = 3$ V.



APPLICATIONS INFORMATION POWER SUPPLY DECOUPLING

For most applications, a single 0.1 μ F capacitor, C_{DC}, adequately decouples the accelerometer from noise on the power supply. However, in some cases, particularly where noise is present at the 140 kHz internal clock frequency (or any harmonic thereof), noise on the supply can cause interference on the ADXL103/ ADXL203 output. If additional decoupling is needed, a 100 Ω (or smaller) resistor or ferrite beads can be inserted in the supply line of the ADXL103/ADXL203. Additionally, a larger bulk bypass capacitor (in the 1 μ F to 22 μ F range) can be added in parallel to C_{DC}.

SETTING THE BANDWIDTH USING C_x AND C_y

The ADXL103/ADXL203 has provisions for band limiting the X_{OUT} and Y_{OUT} pins. Capacitors must be added at these pins to implement low-pass filtering for antialiasing and noise reduction. The equation for the 3 dB bandwidth is

 $f_{-3\,dB} = 1/(2\pi(32 \text{ k}\Omega) \times C_{(X, Y)})$

or more simply,

 $f_{-3 dB} = 5 \ \mu F / C_{(X, Y)}$

The tolerance of the internal resistor (R_{FILT}) can vary typically as much as ±25% of its nominal value (32 k Ω); thus, the bandwidth varies accordingly. A minimum capacitance of 2000 pF for C_X and C_Y is required in all cases.

| Table 7. | Filter | Capacitor | Selection, | C _x and C _y |
|----------|--------|-----------|------------|-----------------------------------|
|----------|--------|-----------|------------|-----------------------------------|

| Bandwidth (Hz) | Capacitor (µF) | |
|----------------|----------------|--|
| 1 | 4.7 | |
| 10 | 0.47 | |
| 50 | 0.10 | |
| 100 | 0.05 | |
| 200 | 0.027 | |
| 500 | 0.01 | |

SELF TEST

The ST pin controls the self test feature. When this pin is set to V_s , an electrostatic force is exerted on the beam of the accelerometer. The resulting movement of the beam allows the user to test if the accelerometer is functional. The typical change in output is 750 mg (corresponding to 750 mV). This pin can be left open-circuit or connected to common in normal use.

Never expose the ST pin to voltages greater than $V_S + 0.3$ V. If the system design is such that this condition cannot be guaranteed (that is, multiple supply voltages are present), a low V_F clamping diode between ST and V_S is recommended.

DESIGN TRADE-OFFS FOR SELECTING FILTER CHARACTERISTICS: THE NOISE/BANDWIDTH TRADE-OFF

The accelerometer bandwidth selected ultimately determines the measurement resolution (smallest detectable acceleration). Filtering can lower the noise floor, improving the resolution of the accelerometer. Resolution is dependent on the analog filter bandwidth at X_{OUT} and Y_{OUT} .

The output of the ADXL103/ADXL203 has a typical bandwidth of 2.5 kHz. The user must filter the signal at this point to limit aliasing errors. The analog bandwidth must be no more than half the analog-to-digital sampling frequency to minimize aliasing. The analog bandwidth can be further decreased to reduce noise and improve resolution.

The ADXL103/ADXL203 noise has the characteristics of white Gaussian noise, which contributes equally at all frequencies and is described in terms of $\mu g/\sqrt{Hz}$ (that is, the noise is proportional to the square root of the accelerometer bandwidth). Limit bandwidth to the lowest frequency needed by the application to maximize the resolution and dynamic range of the accelerometer.

With the single-pole roll-off characteristic, the typical noise of the ADXL103/ADXL203 is determined by

 $rmsNoise = (110 \ \mu g/\sqrt{Hz}) \times (\sqrt{BW \times 1.6})$

At 100 Hz, the noise is

 $rmsNoise = (110 \ \mu g/\sqrt{Hz}) \times (\sqrt{100 \times 1.6}) = 1.4 \ mg$

Often, the peak value of the noise is desired. Peak-to-peak noise can only be estimated by statistical methods. Table 8 is useful for estimating the probabilities of exceeding various peak values, given the rms value.

Table 8. Estimation of Peak-to-Peak Noise

| Peak-to-Peak Value | % of Time That Noise Exceeds Nominal Peak-to-Peak Value |
|--------------------|--|
| $2 \times rms$ | 32 |
| 4 × rms | 4.6 |
| б×rms | 0.27 |
| $8 \times rms$ | 0.006 |

Peak-to-peak noise values give the best estimate of the uncertainty in a single measurement; peak-to-peak noise is estimated by $6 \times \text{rms}$. Table 9 gives the typical noise output of the ADXL103/ ADXL203 for various C_x and C_y values.

Table 9. Filter Capacitor Selection (Cx, Cy)

| Bandwidth (Hz) | C _x , C _γ (μF) | RMS Noise (mg) | Peak-to-Peak Noise Estimate (mg) |
|----------------|---|-------------------|-------------------------------------|
| 10 | 0.47 | 0.4 | 2.6 |
| 50 | 0.1 | 1.0 | 6 |
| 100 | 0.047 | 1.4 | 8.4 |
| 500 | 0.01 | 3.1 | 18.7 |

USING THE ADXL103/ADXL203 WITH OPERATING VOLTAGES OTHER THAN 5 V

The ADXL103/ADXL203 is tested and specified at $V_s = 5 V$; however, it can be powered with V_s as low as 3 V or as high as 6 V. Some performance parameters change as the supply voltage is varied.

The ADXL103/ADXL203 output is ratiometric, so the output sensitivity (or scale factor) varies proportionally to the supply voltage. At $V_s = 3$ V, the output sensitivity is typically 560 mV/g.

The zero *g* bias output is also ratiometric, so the zero *g* output is nominally equal to $V_s/2$ at all supply voltages.

The output noise is not ratiometric but is absolute in volts; therefore, the noise density decreases as the supply voltage increases. This is because the scale factor (mV/g) increases while the noise voltage remains constant. At $V_s = 3$ V, the noise density is typically 190 $\mu g/\sqrt{Hz}$.

Self test response in *g* is roughly proportional to the square of the supply voltage. However, when ratiometricity of sensitivity is factored in with supply voltage, self test response in volts is roughly proportional to the cube of the supply voltage. So at $V_s = 3 V$, the self test response is approximately equivalent to 150 mV or equivalent to 270 mg (typical).

The supply current decreases as the supply voltage decreases. Typical current consumption at $V_{\rm DD}$ = 3 V is 450 $\mu A.$

USING THE ADXL203 AS A DUAL-AXIS TILT SENSOR

One of the most popular applications of the ADXL203 is tilt measurement. An accelerometer uses the force of gravity as an input vector to determine the orientation of an object in space.

An accelerometer is most sensitive to tilt when its sensitive axis is perpendicular to the force of gravity, that is, parallel to the earth's surface. At this orientation, its sensitivity to changes in tilt is highest. When the accelerometer is oriented on axis to gravity, that is, near its +1 g or -1 g reading, the change in output acceleration per degree of tilt is negligible. When the accelerometer is perpendicular to gravity, its output changes nearly 17.5 mg per degree of tilt. At 45°, its output changes at only 12.2 mg per degree, and resolution declines.

Dual-Axis Tilt Sensor: Converting Acceleration to Tilt

When the accelerometer is oriented so both its x-axis and y-axis are parallel to the earth's surface, it can be used as a 2-axis tilt sensor with a roll axis and a pitch axis. After the output signal from the accelerometer is converted to an acceleration that varies between -1 g and +1 g, the output tilt in degrees is calculated as

 $PITCH = ASIN(A_X/1 g)$ $ROLL = ASIN(A_Y/1 g)$

Be sure to account for overranges. It is possible for the accelerometers to output a signal greater than $\pm 1 g$ due to vibration, shock, or other accelerations.